



MULTI LAYER CERAMIC INDUCTOR

High Frequency Application Purpose

Size 0603 (1608)

WL1608 Pb-Free Series

*Contents in this sheet are subject to change without prior notice.



REVISION HISTORY

Rev	P/N	Description	Date
V01	WL1608 Green Material series	First Version	2004-10-07



FEATURES

- 1. Ceramic structure provides high reliability

 high productivity
- 2. Product Design via 3D EM Simulation Skill makes excellent Q and SRF characteristics
- 3. Miniaturized size 1.6 x 0.8 x0.8 mm³
- 4. Pb Free products

APPLICATIONS

Portable electronics and wireless segment include mobile phones, WLAN, HomeRF, Bluetooth application, telecommunication and EMI countermeasure in high frequency circuits.

DESCRIPTION

Walsin Technology Corporation develops a tiny size of 1.6 x 0.8 x 0.8 mm³ Multi Layer Ceramic Inductor (MLCI) consists of a rectangular block of ceramic foils on which low resistive silver metal electrodes are contained and connected via through hole. The inner electrodes are then connected to the two terminations. Adopt 3D EM simulation skill for product design makes Walsin Technology Corporation MLCIs provide excellent Q_Value and Self Resonant Frequency (SRF) characteristics to address application on high frequency band as well as on EMI suppression. The Walsin High frequency chip inductors are manufactured by Multilayer fabrication technology providing excellent electrical performance. The inductors are supplied in reel taping, making them suitable for automatic Pick & Place equipment.

MARKING

Cooperating with environmental protection, We provided Pb-Free products for customer request.

SHAPE AND DIMENSIONS





Polarity mark

Unit: mm (inches)

	L	W	Т	В
1608	1.6 [0.063]	0.8 [0.031]	0.8 [0.032]	0.3 [0.012]
	±0.15 [0.005]	±0.15 [0.005]	±0.15 [0.005]	±0.20 [0.005]

Ordering Information

WL	16 08 08	G	4N7	S	G	Т	03
Product Code	Dimension code	Material	Inductance	Tolerance	Specification	Packing Code	Rated Current
WL: Inductor	160808 = L: 1.6mm W: 0.8mm T: 0.8mm	A, B, C, D, E, F, G	For Ls < 10nH, N = Decimal Point e.g. 4N7 = 4.7nH	S: ± 0.3nH J: ± 5%	N= Normal A= ± 0.2nH G= Green	T= Reeled B = Bulk	03= 250mA or 300mA 02= 150mA or 200mA



ELECTRICAL SPECIFICATION - 0603 (1608) MLCI

Walsin Part Number	L(nH)	Tolerance	Q Min (MHz)	Туріс	al Q @ Fre (MHz)	quency	SRF Typical	RDC Maximum	IDC
	_()		100	100	800	1800	(MHz)	(Ω)	(mA)
WL160808G1N0SGT03	1.0	± 0.3nH	8	13	44	60	8100	0.10	300
WL160808G1N2SGT03	1.2	± 0.3nH	8	13	44	60	8100	0.10	300
WL160808G1N5SGT03	1.5	± 0.3nH	8	14	37	56	8100	0.10	300
WL160808G1N8SGT03	1.8	± 0.3nH	8	12	37	55	8300	0.10	300
WL160808G2N2SGT03	2.2	± 0.3nH	8	12	38	54	8000	0.10	300
WL160808G2N7SGT03	2.7	± 0.3nH	8	13	38	53	7600	0.10	300
WL160808G3N3SGT03	3.3	± 0.3nH	8	12	37	49	5800	0.12	300
WL160808G3N9SGT03	3.9	± 0.3nH	8	14	44	62	5100	0.14	300
WL160808G4N7SGT03	4.7	± 0.3nH	8	15	43	63	4600	0.16	300
WL160808G5N6SGT03	5.6	± 0.3nH	8	15	45	59	4200	0.18	300
WL160808G6N8JGT03	6.8	± 5%	8	15	43	58	3700	0.22	300
WL160808G8N2JGT03	8.2	± 5%	8	15	44	52	3600	0.24	300
WL160808G10NJGT03	10	± 5%	12	17	49	50	3500	0.26	300
WL160808G12NJGT03	12	± 5%	12	15	41	37	2500	0.28	300
WL160808G15NJGT03	15	± 5%	12	17	45	35	2600	0.32	300
WL160808G18NJGT03	18	± 5%	12	16	45	39	2000	0.35	300
WL160808G22NJGT03	22	± 5%	12	16	43	21	1800	0.40	300
WL160808G27NJGT03	27	± 5%	12	16	41	11	1600	0.45	300
WL160808G33NJGT03	33	± 5%	12	19	41	11	1500	0.55	300
WL160808G39NJGT03	39	± 5%	12	19	42	17	1400	0.60	300
WL160808G47NJGT03	47	± 5%	12	17	35	-	1300	0.70	300
WL160808G56NJGT03	56	± 5%	12	19	31	-	1300	0.75	300
WL160808G68NJGT03	68	± 5%	12	19	26	-	1150	0.85	300
WL160808G82NJGT03	82	± 5%	12	19	21	-	1000	0.95	300
WL160808GR10JGT03	100	± 5%	12	19	20	-	1000	1.00	300
WL160808GR12JGT03	120	± 5%	12	19	16	-	950	1.20	300
WL160808GR15JGT03	150	± 5%	12	19	-	-	800	1.50	300
WL160808GR18JGT03	180	± 5%	12	19	-	-	750	1.90	300
WL160808GR22JGT03	220	± 5%	12	18	-	-	680	2.20	300
WL160808GR27JGT03	270	± 5%	12	20	-	-	600	2.50	300

[Test Instruments]

L.Q.: HP4291B (Text Fixture: HP16192A),

SRF: Anritsu 37247B,

- RDC: HP4263B,
- IDC: HP6612C



ELECTRICAL CHARACTERISTICS

Quality Factor vs. Frequency



Inductance vs. Frequency





STANARD TEST and RELIABILITY TEST

- Temperature : 15~35°C
- Humidity : 25%RH~85%RH
- Atmospheric pressure : 96kPa ~ 106kPa

1. Electrical performance test

Item		Method & Criteria
Inductance/Q(Quality factor)	Unit	: nH/Constant
	Test frequency	: 100MHz
	Equipment	: Impedance material analyzer
SRF(Self Resonant Frequency)	Unit	: MHz
	Test frequency	: Frequency sweep(40MHz~20GHz)
	Equipment	: Network analyzer
DC(Direct Current)resistance	Unit	: m Ω (ohm)
	Test frequency	: LCR meter
Rated current	Unit	: mA
	Test frequency	: Current Sweep
	Equipment	: Power supply (DC current source)

2. Reliability Test

тс	Unit : Temperature coefficient of L(PPM/°C)							
	Test	Test Temperature $:-40^{\circ}C \sim 125^{\circ}C$ (referring to L at 20 $^{\circ}C$)						
	Equ	Equipment : TC Chamber(with Impedance analyzer, Ohmmeter, power supply						
		PC, Printer)						
	\diamond	\diamond Basically, DC bias make no difference on L and Q, in glass ceramic inductors						
	Req	uirements	: L shall I	be within ±10% of	of the initial valu	Je.		
Thermal Resistance	Unit		: Mechar	nical, Electrical C	Characteristics			
(Temperature cycle)	Test	condition	:					
		Step	1	2	3	4]	
		Temp.	-40±2°C	room temp.	+125±2° ℃	room temp.		
		Time	30min	2-3min	30min	2-3min		
		Cycle		100 cy	/cles/test			
	Equipment : TC chamber or Temp. controlled chamber (programmable)						e)	
	Proc	edure	: 1) Measu	re the initial valu	es(L, Q, Rdc)			
			2) Carry ou	it the test as des	cribed above			
	3) make measurements after ambient air exposure for 24±2 hours						2 hours.	
	Requirements : No apparent damage							
	L shall be within $\pm 10\%$ of the initial value.							
		Q shall I	be within ±20°	% of the initial va	alue.			



Humidity Resistance	Unit : Mechanical, Electrical Characteristics						
	Test condition : Humidity ; 90-95%RH						
	• Temp :60℃						
	Time : 500±12 hours neglected.						
	Equipmen t : Constant temperature & humidity chamber						
	Procedure : 1) Measure the initial values(L, Q, Rdc)						
	2) Carry out the test as described above						
	3) make measurements after ambient air exposure for 24 \pm 2 hours.						
	Requirements : No apparent damage						
	L shall be within $\pm 10\%$ of the initial value.						
	Q shall be within ±20% of the initial value.						
High Temperature	Unit : Mechanical, Electrical Characteristics						
Resistance	Test condition : Temp.; 125±2℃						
	Time ;1000±12 hours under unloading.						
	Equipment : Constant temperature & humidity chamber						
	Procedure : 1) Measure the initial values(L, Q, Rdc)						
	2) Carry out the test as described above						
	3) make measurements after ambient air exposure for 24 ± 2 hours.						
	Requirements : No apparent damage						
	L shall be within $\pm 10\%$ of the initial value.						
	Q shall be within ±20% of the initial value.						
Low Temperature	Unit : Mechanical, Electrical Characteristics						
Resistance	Test condition : Temp.; -40 $\pm 2^{\circ}C$						
	Time ;1000±12 hours under unloading.						
	Equipment : Constant temperature & humidity chamber						
	Procedure : 1) Measure the initial values(L, Q, Rdc)						
	2) Carry out the test as described above						
	3) Neglect sample in room temp. for 24 \pm 2 hours, then, make						
	measurements.						
	Requirements : No apparent damage						
	L shall be within $\pm 10\%$ of the initial value.						
	Q shall be within ±20% of the initial value.						



8585 Test	Unit : Mechanical, Electrical Characteristics					
	Test condition : Temp. ; 85±2°C					
	. Humidity ; 85±5%					
	.Time ;100±12 hours					
	Equipment : Constant temperature & humidity chamber Procedure :1) Measure the initial values(L, Q, Rdc) 2) Carry out the test as described above 3) Make measurements after the ambient air exposure for 24±2 hours Requirements : No mechanical damage					
	Q shall be within $\pm 20\%$ of the initial value.					
Loading under Damp	Unit : Mechanical, Electrical Characteristics					
Heat	Test condition : Temp :60±2°C					
	. Humidity : 90~95%RH					
	.:Time : 500±12 hours					
	:Apply current: Rated current Equipment : Constant temperature & humidity chamber Procedure :1) Measure the initial values(L, Q, Rdc) 2) Carry out the test as described above 3) Make measurements after the ambient air exposure for 1 to 2 hours of recovery Requirements : No mechanical damage					
	L shall be within ±10% of the initial value.					
	Q shall be within ±20% of the initial value.					
Loading at High	Unit : Mechanical, Electrical Characteristics					
Temperature						
	:Time : 500±12 hours :Apply current: Rated current Equipment : Constant temperature & humidity chamber Procedure :1) Measure the initial values(L, Q, Rdc) 2) Carry out the test as described above 3) Make measurements after the ambient air exposure for 1 to 2 hours of recovery Requirements : No mechanical damage L shall be within ±10% of the initial value. O shall be within ±20% of the initial value					



PACKAGE SPECIFICATION

Carrier Tape Dimensions

- Carrier Tape material : Paper
- Dimension in millimeters



Series	Chip cavity	Chip cavity	Insertion pitch	Insertion pitch	Tape thickness
	А	В	C1	C2	D
1608	1.0 ±0.1	1.8 ± 0.1	4.0 ±0.1	2.0 ±0.05	1.2max

Dimensions of Taping

-Leader and blank section





Appearance of taping









- 1. Reel material : Polystyrene
- 2. Ordering code No., Quantity, Batch No. and Walsin
- 3. Parts per reel : 4,000 pcs / reel



CAUTION OF HANDLING

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects, which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- (4) Medical equipment
- (5) Disaster prevention / crime prevention equipment
- (6) Traffic signal equipment
- (7) Transportation equipment (vehicles, trains, ships, etc.)
- (8) Applications of similar complexity and /or reliability requirements to the applications listed in the above.

Storage condition

- (1) Products should be used in 6 months from the day of WALSIN outgoing inspection, which can be confirmed.
- (2) Storage environment condition.
- Products should be storage in the warehouse on the following conditions.
- Temperature : -10 to +40°C
- Humidity : 30 to 70% relative humidity
- Don't keep products in corrosive gases such as sulfur. Chlorine gas or acid or it may cause oxidization of electrode, resulting in poor solderability.
- Products should be storage on the palette for the prevention of the influence from humidity, dust and son on.
- Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
- Products should be storage under the airtight packaged condition.